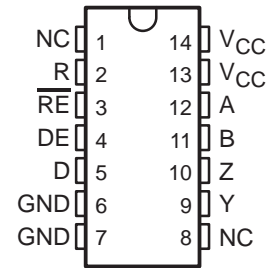


# SN65ALS180, SN75ALS180 DIFFERENTIAL DRIVER AND RECEIVER PAIRS

SLLS052F – AUGUST 1987 – REVISED JUNE 2000

- Meet or Exceed the Requirements of TIA/EIA-422-B, TIA/EIA-485-A† and ITU Recommendation V.11
- High-Speed Advanced Low-Power Schottky Circuitry
- Designed for 25-Mbaud Operation in Both Serial and Parallel Applications
- Low Skew Between Devices . . . 6 ns Max
- Low Supply-Current Requirements . . . 30 mA Max
- Individual Driver and Receiver I/O Pins With Dual  $V_{CC}$  and Dual GND
- Wide Positive and Negative Input/Output Bus Voltage Ranges
- Driver Output Capacity . . .  $\pm 60$  mA
- Thermal Shutdown Protection
- Driver Positive- and Negative-Current Limiting
- Receiver Input Impedance . . . 12 k $\Omega$  Min
- Receiver Input Sensitivity . . .  $\pm 200$  mV Max
- Receiver Input Hysteresis . . . 60 mV Typ
- Operate From a Single 5-V Supply
- Glitch-Free Power-Up and Power-Down Protection

D OR N PACKAGE  
(TOP VIEW)



NC – No internal connection

## description

The SN65ALS180 and SN75ALS180 differential driver and receiver pairs are monolithic integrated circuits designed for bidirectional data communication on multipoint bus-transmission lines. They are designed for balanced transmission lines and meet TIA/EIA-422-B, TIA/EIA-485-A, and ITU Recommendation V.11.

The SN65ALS180 and SN75ALS180 combine a 3-state differential line driver and a differential input line receiver, both of which operate from a single 5-V power supply. The driver and receiver have active-high and active-low enables, respectively, that can be connected together externally to function as a direction control. The driver differential outputs and the receiver differential inputs are connected to separate terminals for greater flexibility and are designed to offer minimum loading to the bus when the driver is disabled or  $V_{CC} = 0$ .

These ports feature wide positive and negative common-mode voltage ranges, making the device suitable for party-line applications.

The SN65ALS180 is characterized for operation from  $-40^{\circ}\text{C}$  to  $85^{\circ}\text{C}$ . The SN75ALS180 is characterized for operation from  $0^{\circ}\text{C}$  to  $70^{\circ}\text{C}$ .



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

† These devices meet or exceed the requirements of TIA/EIA-485-A, except for the Generator Contention Test (para. 3.4.2) and the Generator Current Limit (para. 3.4.3). The applied test voltage ranges are  $-6$  V to  $8$  V for the SN75ALS180 and  $-4$  V to  $8$  V for the SN65ALS180.

PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

**TEXAS  
INSTRUMENTS**

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# SN65ALS180, SN75ALS180

## DIFFERENTIAL DRIVER AND RECEIVER PAIRS

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### Function Tables

#### DRIVER

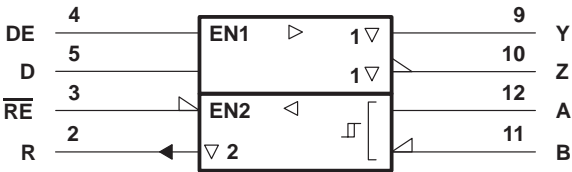
INPUT D	ENABLE DE	OUTPUTS	
		Y	Z
H	H	H	L
L	H	L	H
X	L	Z	Z

#### RECEIVER

DIFFERENTIAL INPUTS A-B	ENABLE RE	OUTPUT R
$V_{ID} \geq 0.2\text{ V}$	L	H
$-0.2\text{ V} < V_{ID} < 0.2\text{ V}$	L	?
$V_{ID} \leq -0.2\text{ V}$	L	L
X	H	Z
Open	L	H

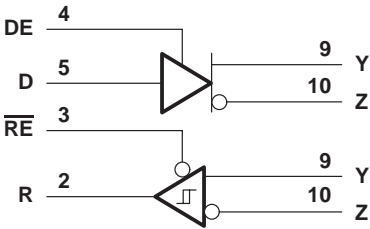
H = high level, L = low level, ? = indeterminate,  
X = irrelevant, Z = high impedance (off)

### logic symbol†



† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

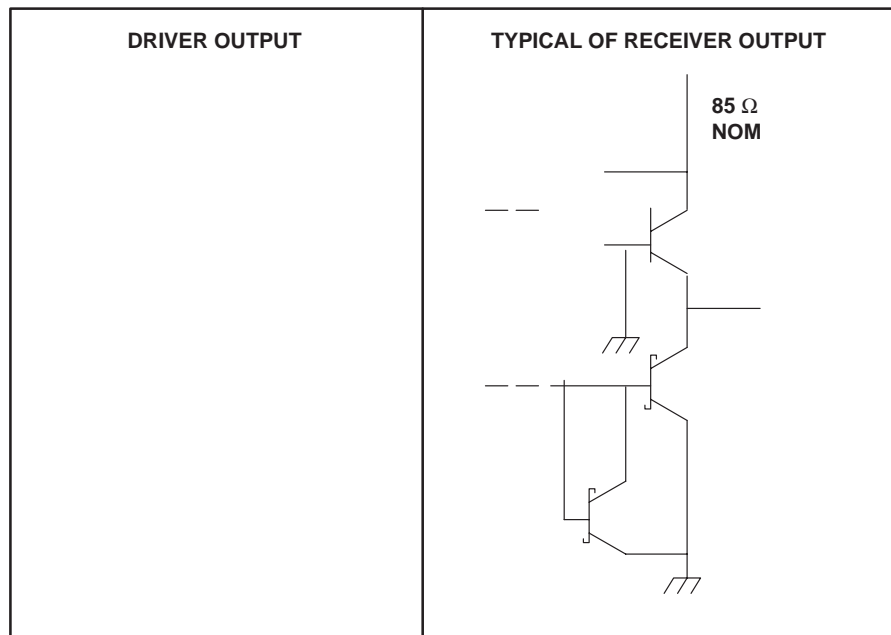
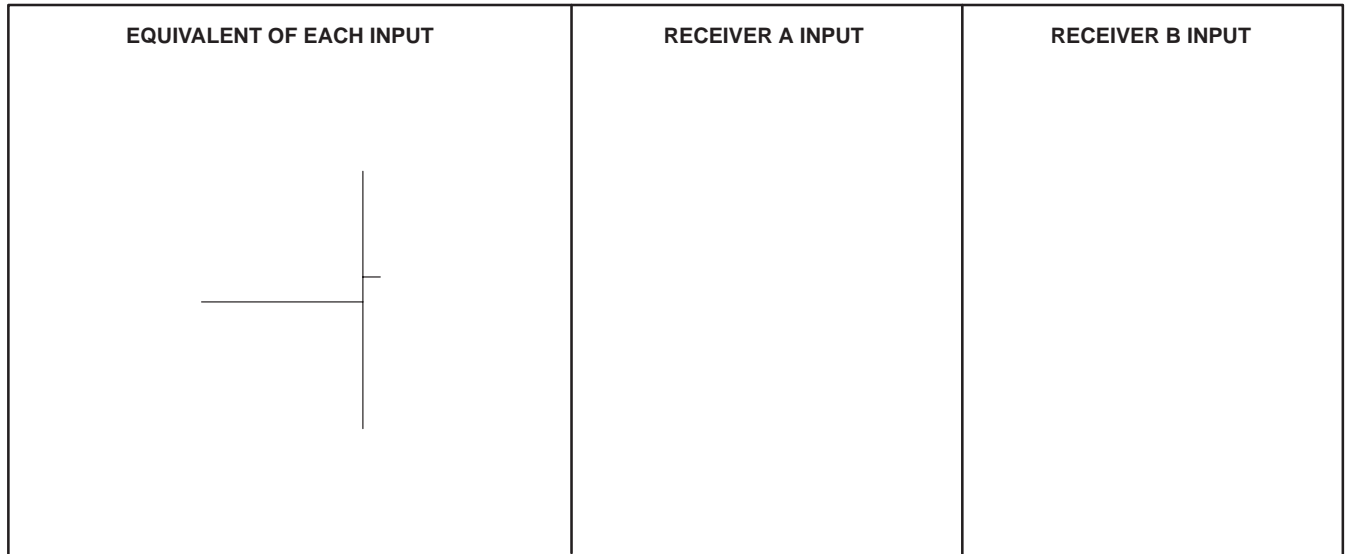
### logic diagram (positive logic)



# SN65ALS180, SN75ALS180 DIFFERENTIAL DRIVER AND RECEIVER PAIRS

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## schematics of inputs and outputs



# SN65ALS180, SN75ALS180

## DIFFERENTIAL DRIVER AND RECEIVER PAIRS

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### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)<sup>†</sup>

Supply voltage, $V_{CC}$ (see Note 1)	7 V
Voltage range at any bus terminal	–10 V to 15 V
Enable input voltage, $V_I$	5.5 V
Package thermal impedance, $\theta_{JA}$ (see Note 2): D package	86°C/W
N package	80°C/W
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	260°C
Storage temperature range, $T_{st}$	–65°C to 150°C

<sup>†</sup> Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. All voltage values, except differential I/O bus voltage, are with respect to network ground terminal.  
2. The package thermal impedance is calculated in accordance with JESD 51.

### recommended operating conditions

		MIN	NOM	MAX	UNIT
Supply voltage, V <sub>CC</sub>		4.75	5	5.25	V
Voltage at any bus terminal (separately or common mode), V <sub>I</sub> or V <sub>IC</sub>		12			V
		−7			
High-level input voltage, V <sub>IH</sub>	D, DE, and $\overline{RE}$	2			V
Low-level input voltage, V <sub>IL</sub>	D, DE, and $\overline{RE}$	0.8			V
Differential input voltage, V <sub>ID</sub> (see Note 3)		±12			V
High-level output current, I <sub>OH</sub>	Driver	−60			mA
	Receiver	−400			μA
Low-level output current, I <sub>OL</sub>	Driver	60			mA
	Receiver	8			
Operating free-air temperature, T <sub>A</sub>	SN65ALS180	−40	85		°C
	SN75ALS180	0	70		

NOTE 3: Differential-input/output bus voltage is measured at the noninverting terminal, A/Y, with respect to the inverting terminal, B/Z.



# SN65ALS180, SN75ALS180 DIFFERENTIAL DRIVER AND RECEIVER PAIRS

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## DRIVERS

**electrical characteristics over recommended ranges of supply voltage and operating free-air temperature range (unless otherwise noted)**

PARAMETER	TEST CONDITION†	MIN	TYP‡	MAX	UNIT
$V_{IK}$ Input clamp voltage	$I_I = -18\text{ mA}$			-1.5	V
$V_O$ Output voltage	$I_O = 0$	0		6	V
$ V_{OD1} $ Differential output voltage	$I_O = 0$	1.5		6	V
$ V_{OD2} $ Differential output voltage	$R_L = 100\ \Omega$ , See Figure 1	$1/2 V_{OD1}$ or 2§			V
	$R_L = 54\ \Omega$ , See Figure 1	1.5	2.5	5	
$V_{OD3}$ Differential output voltage	$V_{test} = -7\text{ V to }12\text{ V}$ , See Figure 2	1.5		5	V
$\Delta V_{OD} $ Change in magnitude of differential output voltage¶	$R_L = 54\ \Omega$ or $100\ \Omega$ , See Figure 1			$\pm 0.2$	V
$V_{OC}$ Common-mode output voltage	$R_L = 54\ \Omega$ or $100\ \Omega$ , See Figure 1			3 -1	V
$\Delta V_{OC} $ Change in magnitude of common-mode output voltage¶	$R_L = 54\ \Omega$ or $100\ \Omega$ , See Figure 1			$\pm 0.2$	V
$I_O$ Output current	Output disabled (see Note 4)	$V_O = 12\text{ V}$		1	mA
		$V_O = -7\text{ V}$		-0.8	
$I_{IH}$ High-level input current	$V_I = 2.4\text{ V}$			20	$\mu\text{A}$
$I_{IL}$ Low-level input current	$V_I = 0.4\text{ V}$			-400	$\mu\text{A}$
$I_{OS}$ Short-circuit output current#	$V_O = -6\text{ V}$	SN75ALS180		-250	mA
	$V_O = -4\text{ V}$	SN65ALS180		-250	
	$V_O = 0$	All		-150	
	$V_O = V_{CC}$	All		250	
	$V_O = 8\text{ V}$	All		250	
$I_{CC}$ Supply current	No load	Driver outputs enabled, Receiver disabled	25	30	mA
		Outputs disabled	19	26	

† The power-off measurement in TIA/EIA-422-B applies to disabled outputs only and is not applied to combined inputs and outputs.

‡ All typical values are at  $V_{CC} = 5\text{ V}$ ,  $T_A = 25^\circ\text{C}$ .

§ The minimum  $V_{OD2}$  with  $100\text{-}\Omega$  load is either  $1/2 V_{OD2}$  or  $2\text{ V}$ , whichever is greater.

¶  $\Delta|V_{OD}|$  and  $\Delta|V_{OC}|$  are the changes in magnitude of  $V_{OD}$  and  $V_{OC}$ , respectively, that occur when the input is changed from a high level to a low level.

# Duration of the short circuit should not exceed one second for this test.

NOTE 4: This applies for both power on and off; refer to TIA/EIA-485-A for exact conditions. The TIA/EIA-422-B limit does not apply for a combined driver and receiver terminal.

**switching characteristics over recommended ranges of supply voltage and operating free-air temperature**

PARAMETER	TEST CONDITIONS	MIN	TYP‡	MAX	UNIT
$t_{d(OD)}$ Differential output delay time	$R_L = 54\ \Omega$ , $C_L = 50\text{ pF}$ , See Figure 3	3	8	13	ns
Pulse skew ( $ t_{d(ODH)} - t_{d(ODL)} $ )	$R_L = 54\ \Omega$ , $C_L = 50\text{ pF}$ , See Figure 3		1	6	ns
$t_{t(OD)}$ Differential output transition time	$R_L = 54\ \Omega$ , $C_L = 50\text{ pF}$ , See Figure 3	3	8	13	ns
$t_{PZH}$ Output enable time to high level	$R_L = 110\ \Omega$ , See Figure 4		23	50	ns
$t_{PZL}$ Output enable time to low level	$R_L = 110\ \Omega$ , See Figure 5		19	24	ns
$t_{PHZ}$ Output disable time from high level	$R_L = 110\ \Omega$ , See Figure 4		8	13	ns
$t_{PLZ}$ Output disable time from low level	$R_L = 110\ \Omega$ , See Figure 5		8	13	ns

‡ All typical values are at  $V_{CC} = 5\text{ V}$  and  $T_A = 25^\circ\text{C}$ .



# SN65ALS180, SN75ALS180 DIFFERENTIAL DRIVER AND RECEIVER PAIRS

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## SYMBOL EQUIVALENTS

DATA-SHEET PARAMETER	TIA/EIA-422-B	TIA/EIA-485-A
$V_O$	$V_{Oa}, V_{Ob}$	$V_{Oa}, V_{Ob}$
$ V_{OD1} $	$V_O$	$V_O$
$ V_{OD2} $	$V_t (R_L = 100 \Omega)$	$V_t (R_L = 54 \Omega)$
$ V_{OD3} $		$V_t$ (test termination measurement 2)
$V_{test}$		$V_{tst}$
$\Delta V_{OD} $	$  V_t  -  \bar{V}_t  $	$  V_t  -  \bar{V}_t  $
$V_{OC}$	$ V_{os} $	$ V_{os} $
$\Delta V_{OC} $	$ V_{os} - \bar{V}_{os} $	$ V_{os} - \bar{V}_{os} $
$I_{OS}$	$ I_{sa} ,  I_{sb} $	
$I_O$	$ I_{xa} ,  I_{xb} $	$I_{ia}, I_{ib}$

## RECEIVERS

electrical characteristics over recommended ranges of common-mode input voltage, supply voltage, and operating free-air temperature (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP†	MAX	UNIT
$V_{IT+}$ Positive-going input threshold voltage	$V_O = 2.7 \text{ V}$ , $I_O = -0.4 \text{ mA}$			0.2	V
$V_{IT-}$ Negative-going input threshold voltage	$V_O = 0.5 \text{ V}$ , $I_O = 8 \text{ mA}$	-0.2‡			V
$V_{hys}$ Hysteresis voltage ( $V_{IT+} - V_{IT-}$ )			60		mV
$V_{IK}$ Enable-input clamp voltage	$I_I = -18 \text{ mA}$			-1.5	V
$V_{OH}$ High-level output voltage	$V_{ID} = 200 \text{ mV}$ , $I_{OH} = -400 \mu\text{A}$ , See Figure 6	2.7			V
$V_{OL}$ Low-level output voltage	$V_{ID} = -200 \text{ mV}$ , $I_{OL} = 8 \text{ mA}$ , See Figure 6			0.45	V
$I_{OZ}$ High-impedance-state output current	$V_O = 0.4 \text{ V to } 2.4 \text{ V}$			$\pm 20$	$\mu\text{A}$
$I_I$ Line input current	Other input = 0 V (see Note 5)	$V_I = 12 \text{ V}$		1	mA
		$V_I = -7 \text{ V}$		-0.8	
$I_{IH}$ High-level enable-input current	$V_{IH} = 2.7 \text{ V}$			20	$\mu\text{A}$
$I_{IL}$ Low-level enable-input current	$V_{IL} = 0.4 \text{ V}$			-100	$\mu\text{A}$
$r_i$ Input resistance		12			k $\Omega$
$I_{OS}$ Short-circuit output current	$V_{ID} = 200 \text{ mV}$ , $V_O = 0$	-15		-85	mA
$I_{CC}$ Supply current	No load	Receiver outputs enabled, Driver inputs disabled		19	mA
		Outputs disabled		19	

† All typical values are at  $V_{CC} = 5 \text{ V}$ ,  $T_A = 25^\circ\text{C}$ .

‡ The algebraic convention, in which the less positive (more negative) limit is designated minimum, is used in this data sheet for common-mode input voltage and threshold voltage levels only.

NOTE 5: This applies for both power on and power off. Refer to TIA/EIA-485-A for exact conditions.



**switching characteristics over recommended ranges of supply voltage and operating free-air temperature**

PARAMETER	TEST CONDITIONS	MIN	TYP†	MAX	UNIT
$t_{PLH}$ Propagation delay time, low- to high-level output	$V_{ID} = -1.5\text{ V to }1.5\text{ V}$ , See Figure 7 $C_L = 15\text{ pF}$	9	14	19	ns
$t_{PHL}$ Propagation delay time, high- to low-level output	$V_{ID} = -1.5\text{ V to }1.5\text{ V}$ , See Figure 7 $C_L = 15\text{ pF}$	9	14	19	ns
Skew ( $ t_{PHL} - t_{PLH} $ )	$V_{ID} = -1.5\text{ V to }1.5\text{ V}$ , See Figure 7 $C_L = 15\text{ pF}$		2	6	ns
$t_{PZH}$ Output enable time to high level	$C_L = 15\text{ pF}$ , See Figure 8		7	14	ns
$t_{PZL}$ Output enable time to low level	$C_L = 15\text{ pF}$ , See Figure 8		7	14	ns
$t_{PHZ}$ Output disable time from high level	$C_L = 15\text{ pF}$ , See Figure 8		20	35	ns
$t_{PLZ}$ Output disable time from low level	$C_L = 15\text{ pF}$ , See Figure 8		8	17	ns

† All typical values are at  $V_{CC} = 5\text{ V}$ ,  $T_A = 25^\circ\text{C}$ .

### PARAMETER MEASUREMENT INFORMATION

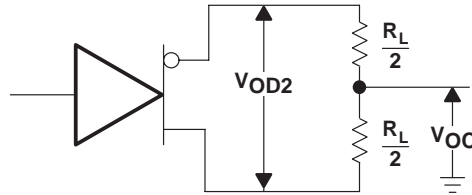


Figure 1. Driver  $V_{OD}$  and  $V_{OC}$

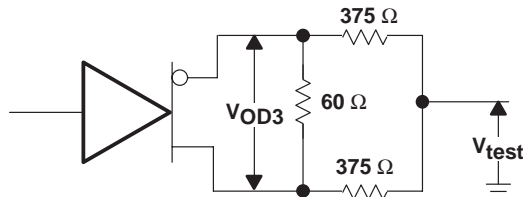
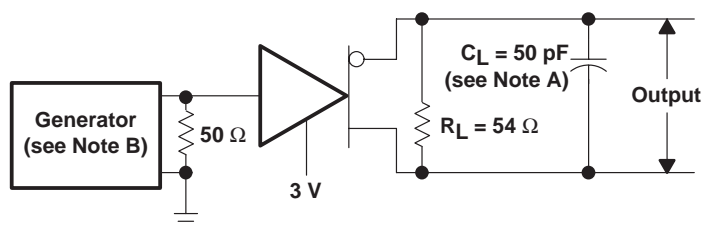


Figure 2. Driver  $V_{OD3}$

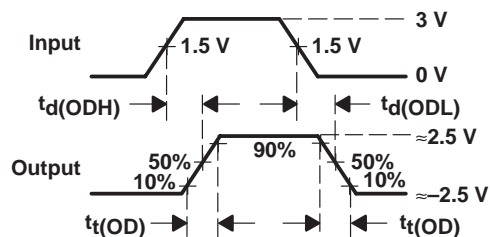
# SN65ALS180, SN75ALS180 DIFFERENTIAL DRIVER AND RECEIVER PAIRS

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## PARAMETER MEASUREMENT INFORMATION



TEST CIRCUIT

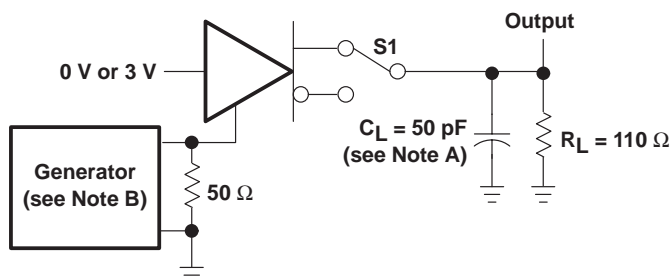


VOLTAGE WAVEFORMS

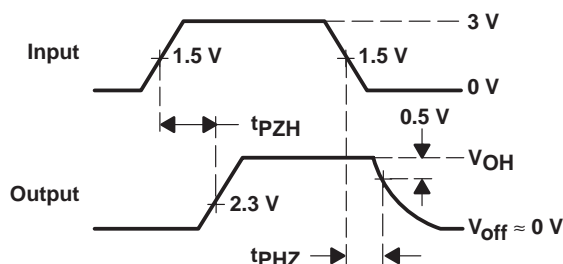
NOTES: A.  $C_L$  includes probe and jig capacitance.

B. The input pulse is supplied by a generator having the following characteristics:  $PRR \leq 1$  MHz, 50% duty cycle,  $t_r \leq 6$  ns,  $t_f \leq 6$  ns,  $Z_O = 50 \Omega$ .

Figure 3. Driver Test Circuit and Voltage Waveforms



TEST CIRCUIT

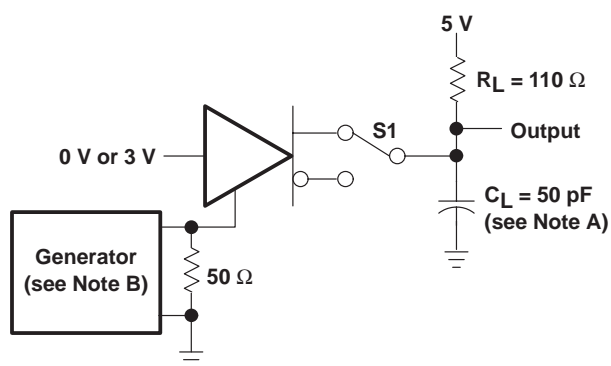


VOLTAGE WAVEFORMS

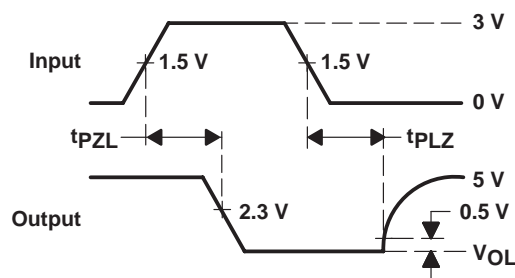
NOTES: A.  $C_L$  includes probe and jig capacitance.

B. The input pulse is supplied by a generator having the following characteristics:  $PRR \leq 1$  MHz, 50% duty cycle,  $t_r \leq 6$  ns,  $t_f \leq 6$  ns,  $Z_O = 50 \Omega$ .

Figure 4. Driver Test Circuit and Voltage Waveforms



TEST CIRCUIT



VOLTAGE WAVEFORMS

NOTES: A.  $C_L$  includes probe and jig capacitance.

B. The input pulse is supplied by a generator having the following characteristics:  $PRR \leq 1$  MHz, 50% duty cycle,  $t_r \leq 6$  ns,  $t_f \leq 6$  ns,  $Z_O = 50 \Omega$ .

Figure 5. Driver Test Circuit and Voltage Waveforms



## PARAMETER MEASUREMENT INFORMATION

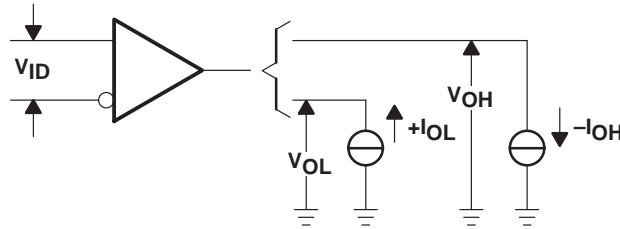
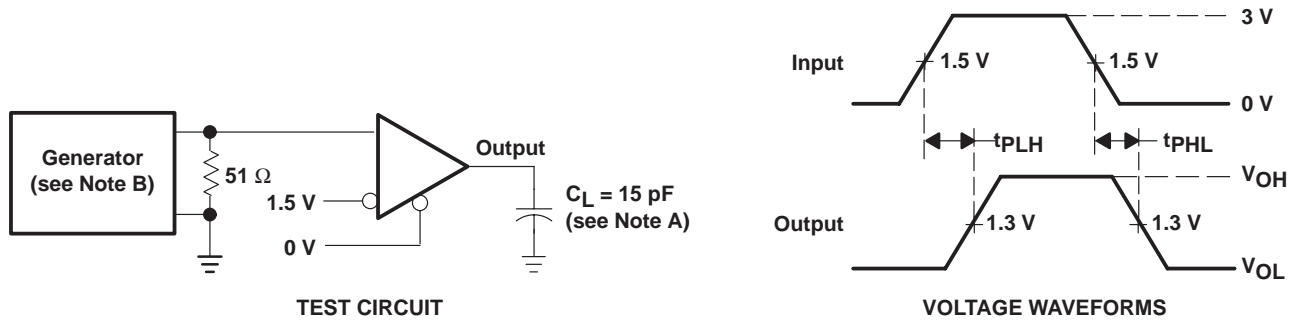


Figure 6. Receiver  $V_{OH}$  and  $V_{OL}$



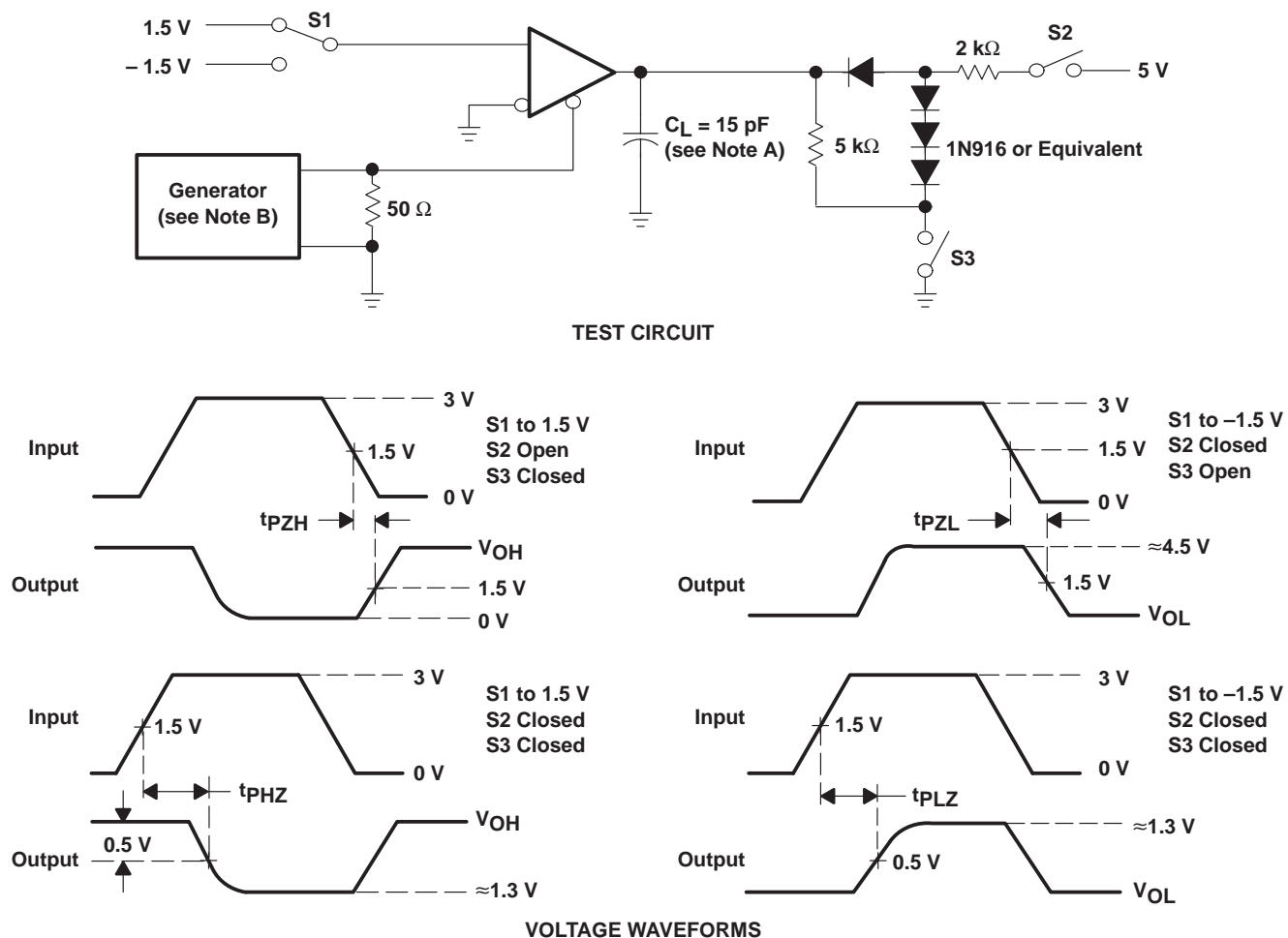
- NOTES: A.  $C_L$  includes probe and jig capacitance.  
B. The input pulse is supplied by a generator having the following characteristics:  $PRR \leq 1$  MHz, 50% duty cycle,  $t_r \leq 6$  ns,  $t_f \leq 6$  ns,  $Z_O = 50 \Omega$ .

Figure 7. Receiver Test Circuit and Voltage Waveforms

# SN65ALS180, SN75ALS180 DIFFERENTIAL DRIVER AND RECEIVER PAIRS

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## PARAMETER MEASUREMENT INFORMATION



NOTES: A.  $C_L$  includes probe and jig capacitance.  
B. The input pulse is supplied by a generator having the following characteristics:  $PRR \leq 1 \text{ MHz}$ , 50% duty cycle,  $t_r \leq 6 \text{ ns}$ ,  $t_f \leq 6 \text{ ns}$ ,  $Z_O = 50 \Omega$ .

Figure 8. Receiver Test Circuit and Voltage Waveforms

# TYPICAL CHARACTERISTICS – DRIVERS

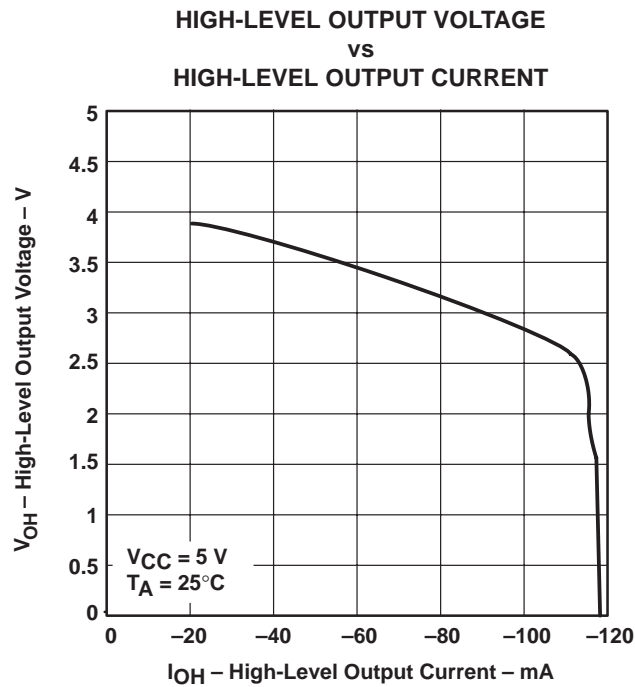


Figure 9

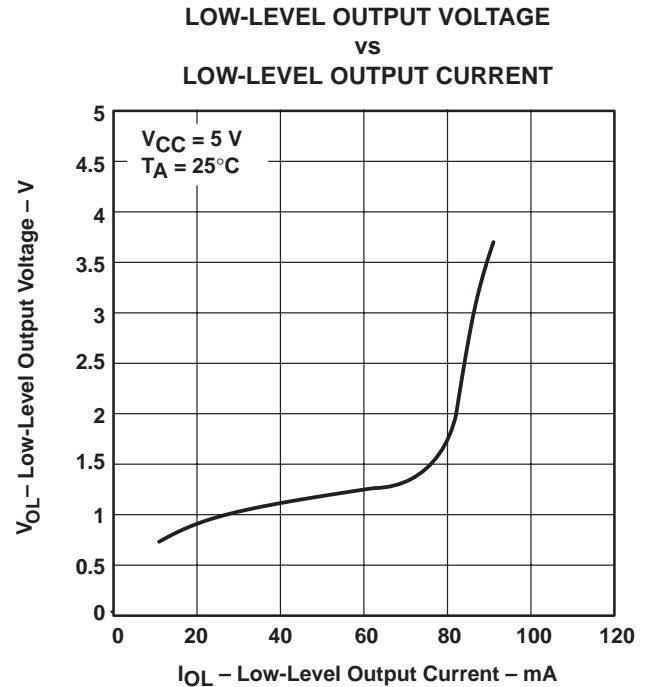


Figure 10

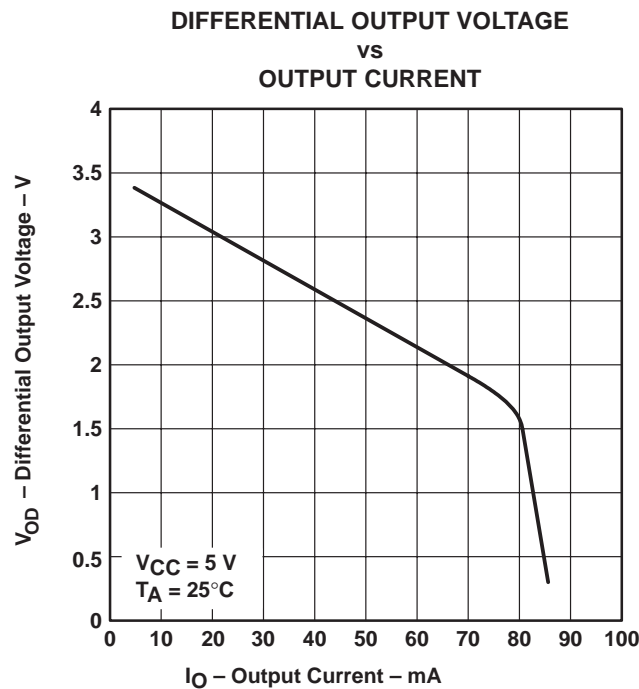


Figure 11

SN65ALS180, SN75ALS180  
DIFFERENTIAL DRIVER AND RECEIVER PAIRS

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TYPICAL CHARACTERISTICS – RECEIVERS

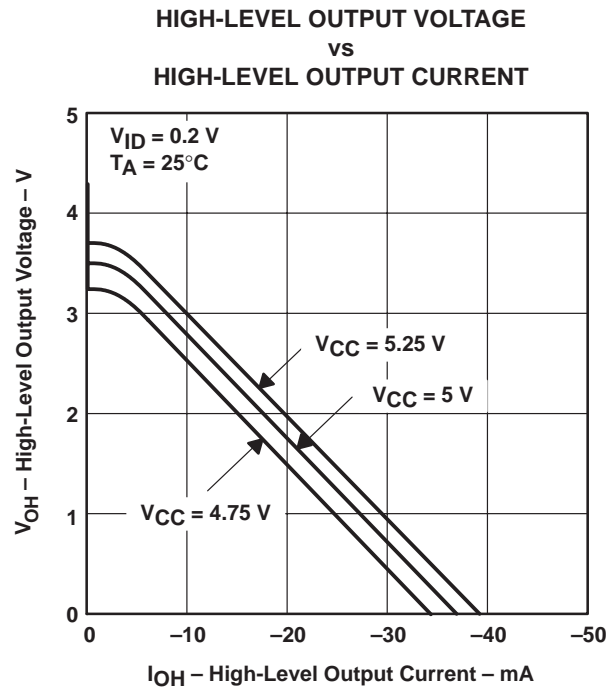


Figure 12

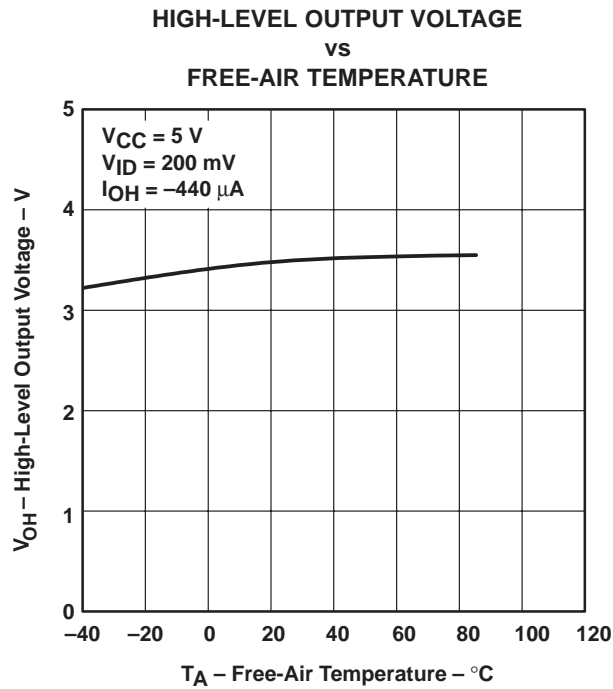


Figure 13

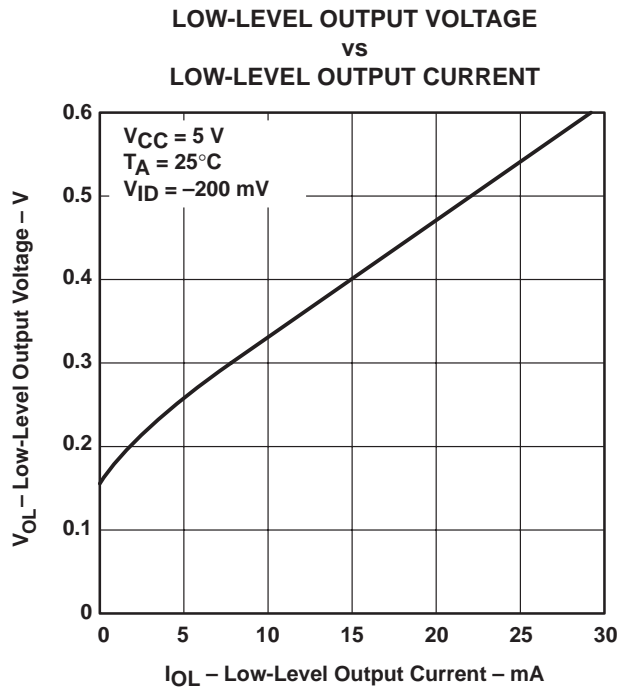


Figure 14

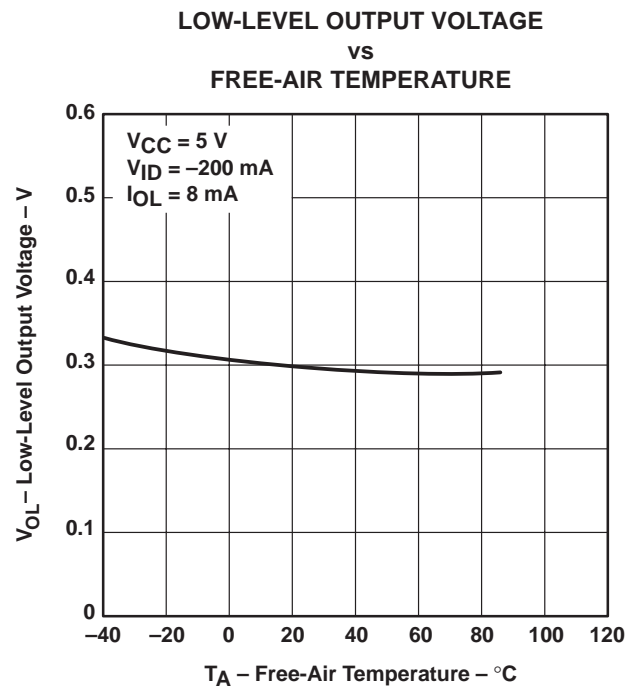


Figure 15

TYPICAL CHARACTERISTICS – RECEIVERS

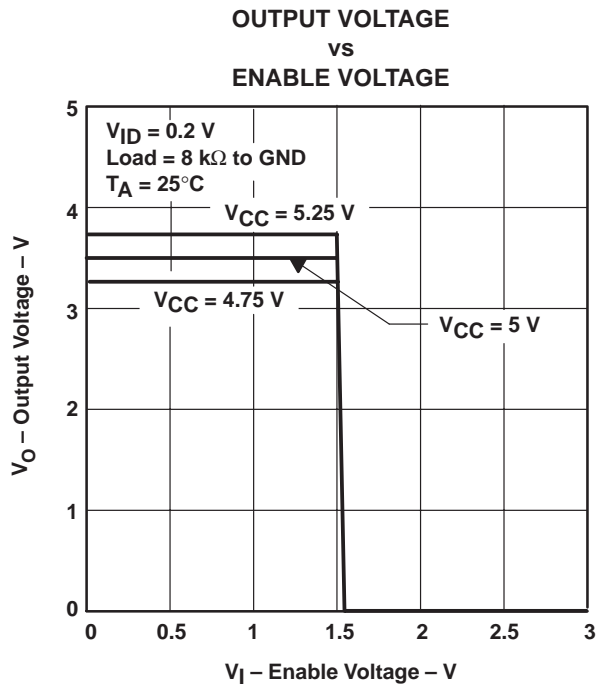


Figure 16

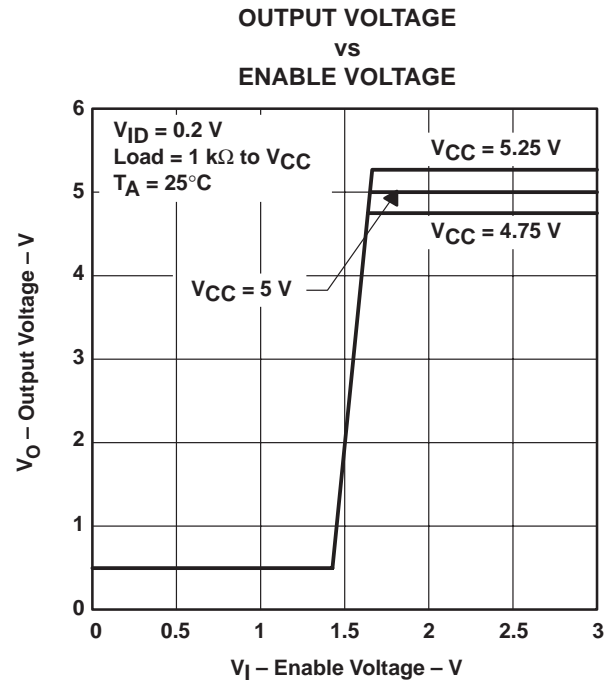
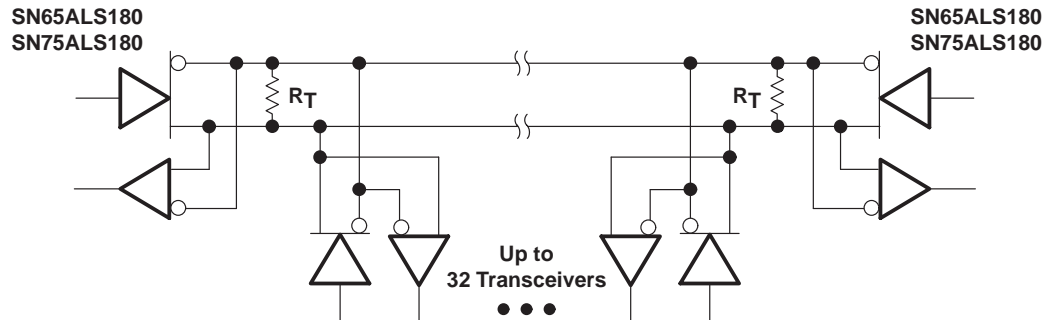


Figure 17

APPLICATION INFORMATION



NOTE A: The line should terminate at both ends in its characteristic impedance ( $R_T = Z_0$ ). Stub lengths off the main line should be kept as short as possible.

Figure 18. Typical Application Circuit

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